Search Notes

Application/Control No.	Applicant(s)/Pate Reexamination	ent under
10/814,572	MITCHELL ET AL.	
Examiner	Art Unit	

2416

HABTE MERED

SEARCHED				
Class	Subclass	Date	Examiner	
370	218	12/1/2008	НМ	
370	219	12/1/2008	НМ	
370	230	12/1/2008	НМ	
370	217	12/1/2008	НМ	
370	220	12/1/2008	НМ	
370	216	12/1/2008	НМ	
370	225-228	12/1/2008	НМ	
370	245	12/1/2008	НМ	
714	4	12/1/2008	НМ	
709	201	12/1/2008	НМ	
709	245	12/1/2008	НМ	

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Searched EAST DB:USPAT, USPG-PUB, JPO, and EPo	12/1/2008	НМ		
Searched Palm Inventor's DB	12/1/2008	НМ		
Searached IEEE	12/1/2008	НМ		